

**Notice of References Cited**

Application/Control No.

10/531,768

Applicant(s)/Patent Under  
Reexamination  
WATANABE, TOHRU

Examiner

AMY HSU

Art Unit

2622

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,018,363 A	01-2000	Horii, Hiroyuki	348/219.1
*	B	US-6,295,087 B1	09-2001	Nohda, Shigetoshi	348/234
*	C	US-2002/0176014 A1	11-2002	Bompard, Frederic	348/253
*	D	US-2003/0048361 A1	03-2003	Safai, Mohammad A.	348/222.1
*	E	US-6,542,192 B2	04-2003	Akiyama et al.	348/333.11
*	F	US-6,904,166 B2	06-2005	Hsia et al.	382/162
*	G	US-7,068,314 B1	06-2006	Nakajima et al.	348/273
*	H	US-7,116,358 B1	10-2006	Sasaki, Gen	348/222.1
*	I	US-7,136,097 B1	11-2006	Toyoda et al.	348/222.1
*	J	US-2002/0047908	04-2002	Mise et al.	348/222
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

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